

Notice of References Cited	Application/Control No. 10/718,242	Applicant(s)/Patent Under Reexamination CHIN ET AL.	
	Examiner Temica M. Beamer	Art Unit 2617	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0017908	01-2004	Pelletier et al.	379/207.02
*	B	US-5,155,760	10-1992	Johnson et al.	379/88.01
	C	US-			
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	F	US-			
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FOREIGN PATENT DOCUMENTS

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	N					
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NON-PATENT DOCUMENTS

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